

Notice of References Cited

Application/Control No.

10/550,103

Applicant(s)/Patent Under
Reexamination
OKAMURA, TOKUJI

Examiner

ALVIN J. GRANT

Art Unit

3723

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-754,000 A	03-1904	Name not available	401/146
*	B	US-1,131,863 A	03-1915	Name not available	15/176.6
*	C	US-2,360,745 A	10-1944	VOGEL SIDNEY A	15/167.1
*	D	US-2,582,404 A	01-1952	ZAVADA FRANK J	401/186
*	E	US-3,720,975 A	03-1973	Nelson, Stanley E.	15/167.1
*	F	US-4,387,479 A	06-1983	Kigyos, Frank	15/167.1
*	G	US-4,691,404 A	09-1987	Tarrson et al.	15/167.1
*	H	US-4,808,109 A	02-1989	Thornton, Thomas F.	433/216
*	I	US-D304,785 S	11-1989	Tarrson et al.	D4/104
*	J	US-4,963,046 A	10-1990	Eguchi, Yasuteru	401/160
*	K	US-5,150,495 A	09-1992	Discio et al.	15/167.1
*	L	US-5,488,751 A	02-1996	Gekhter et al.	15/167.1
*	M	US-5,564,152 A	10-1996	Jeannet et al.	15/167.1

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,630,244 A	05-1997	Chang, Ching-Min	15/167.1
*	B	US-5,673,452 A	10-1997	Chang et al.	15/167.1
*	C	US-5,735,012 A	04-1998	Heinzelman et al.	15/167.1
*	D	US-5,766,008 A	06-1998	Hughes, Michael F.	433/165
*	E	US-5,846,010 A	12-1998	Barbalich, Daniel B.	401/186
*	F	US-5,875,510 A	03-1999	Lamond et al.	15/167.1
*	G	US-5,903,949 A	05-1999	Halm, Hans	15/167.1
*	H	US-5,934,295 A	08-1999	Gekhter et al.	132/309
*	I	US-6,108,869 A	08-2000	Meessmann et al.	16/430
*	J	US-D435,292 S	12-2000	Dragan et al.	D24/152
*	K	US-RE37,190 E	05-2001	Stowell et al.	16/422
*	L	US-6,332,233 B1	12-2001	Proulx, Genevieve C.	15/167.1
*	M	US-6,325,626 B1	12-2001	Blass, Jacob Moses	433/141

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,601,272 B2	08-2003	Stvartak et al.	16/430
*	B	US-6,668,416 B1	12-2003	Georgi et al.	15/167.1
*	C	US-2004/0025272 A1	02-2004	Stvartak et al.	15/143.1
*	D	US-6,932,603 B2	08-2005	Han et al.	433/80
*	E	US-6,968,590 B2	11-2005	Ponzini, Eligio	15/167.1
*	F	US-7,086,116 B2	08-2006	Broecker et al.	15/167.1
*	G	US-7,232,310 B2	06-2007	Han et al.	433/80
*	H	US-7,458,125 B2	12-2008	Hohlbein et al.	15/143.1
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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